

GE03N70

N-CHANNEL ENHANCEMENT MODE POWER MOSFET

BVDSS	600/650/700V
RDS(ON)	4.0Ω
ID	3.3A

Description

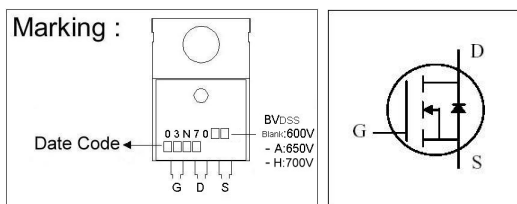
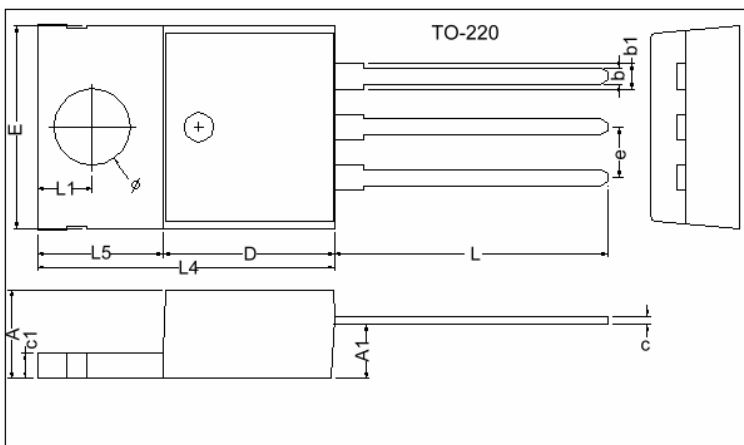
The GE03N70 series are specially designed as main switching devices for universal 90~265VAC off-line AC/DC converter applications. TO-220 type provide high blocking voltage to overcome voltage surge and sag in the toughest power system with the best combination of fast switching, ruggedized design and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications. The device is suited for switch mode power supplies, DC-AC converters and high current high speed switching circuits.

Features

- *Dynamic dv/dt Rating
- *Simple Drive Requirement
- *Repetitive Avalanche Rated
- *Fast Switching Speed

Package Dimensions



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	4.40	4.80	c1	1.25	1.45
b	0.76	1.00	b1	1.17	1.47
c	0.36	0.50	L	13.25	14.25
D	8.60	9.00	e	2.54 REF.	
E	9.80	10.4	L1	2.60	2.89
L4	14.7	15.3	Ø	3.71	3.96
L5	6.20	6.60	A1	2.60	2.80

Absolute Maximum Ratings

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V_{DS}	600/650/700	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current, $V_{GS}@10V$	$I_D @T_C=25^\circ C$	3.3	A
Continuous Drain Current, $V_{GS}@10V$	$I_D @T_C=100^\circ C$	2.1	A
Pulsed Drain Current ¹	I_{DM}	13.2	A
Total Power Dissipation	$P_D @T_C=25^\circ C$	45	W
Linear Derating Factor		0.36	W/ $^\circ C$
Single Pulse Avalanche Energy ²	E_{AS}	85	mJ
Avalanche Current	I_{AR}	3.3	A
Repetitive Avalanche Energy	E_{AR}	3.3	mJ
Operating Junction and Storage Temperature Range	T_j, T_{stg}	-55 ~ +150	$^\circ C$

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-case	R_{thj-c}	2.8	$^\circ C/W$
Thermal Resistance Junction-ambient	R_{thj-a}	62	$^\circ C/W$

Electrical Characteristics(T_j = 25°C Unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV _{DSS}	600	-	-	V	V _{GS} =0, I _D =250uA -
		650	-	-	V	V _{GS} =0, I _D =250uA A
		700	-	-	V	V _{GS} =0, I _D =250uA H
Breakdown Voltage Temperature Coefficient	ΔBV _{DSS} / ΔT _j	-	0.6	-	V/°C	Reference to 25°C, I _D =1mA
Gate Threshold Voltage	V _{GS(th)}	2.0	-	4.0	V	V _{DS} =V _{GS} , I _D =250uA
Forward Transconductance	g _{fs}	-	2.0	-	S	V _{DS} =10V, I _D =1.6A
Gate-Source Leakage Current	I _{GSS}	-	-	±1	uA	V _{GS} = ±20V
Drain-Source Leakage Current(T _j =25°C)	I _{DSS}	-	-	100	uA	V _{DS} =600V, V _{GS} =0
Drain-Source Leakage Current(T _j =150°C)		-	-	500	uA	V _{DS} =480V, V _{GS} =0
Static Drain-Source On-Resistance	R _{DS(ON)}	-	-	4.0	Ω	V _{GS} =10V, I _D =1.6A
Total Gate Charge ³	Q _g	-	11.4	-	nC	I _D =3.3A V _{DS} =480V V _{GS} =10V
Gate-Source Charge	Q _{gs}	-	3.1	-		
Gate-Drain ("Miller") Change	Q _{gd}	-	4.2	-		
Turn-on Delay Time ³	T _{d(on)}	-	8.4	-	ns	V _{DD} =300V I _D =3.3A V _{GS} =10V R _G =10Ω R _D =91Ω
Rise Time	T _r	-	6	-		
Turn-off Delay Time	T _{d(off)}	-	17.7	-		
Fall Time	T _f	-	5.9	-		
Input Capacitance	C _{iss}	-	600	-	pF	V _{GS} =0V V _{DS} =25V f=1.0MHz
Output Capacitance	C _{oss}	-	45	-		
Reverse Transfer Capacitance	C _{rss}	-	4	-		

Source-Drain Diode

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Forward On Voltage ³	V _{SD}	-	-	1.5	V	I _S =3.3A, V _{GS} =0V, T _j =25°C
Continuous Source Current (Body Diode)	I _S	-	-	3.3	A	V _D = V _G =0V, V _S =1.5V
Pulsed Source Current (Body Diode) ¹	I _{SM}	-	-	13.2	A	

Notes: 1. Pulse width limited by safe operating area.

2. Staring T_j=25°C, V_{DD}=50V, L=15mH, R_G=25Ω, I_{AS}=3.3A.

3. Pulse width ≤ 300us, duty cycle ≤ 2%.

Characteristics Curve

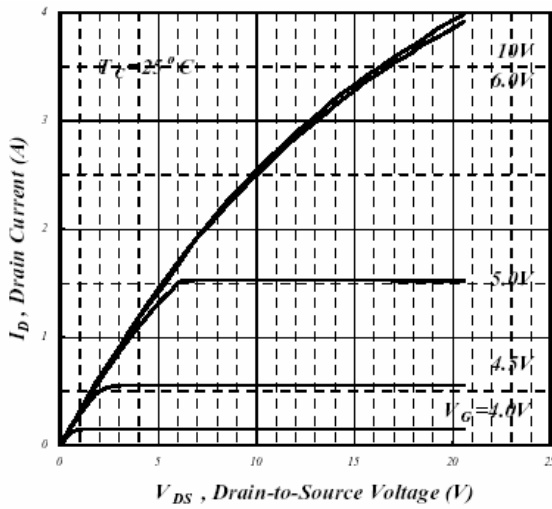


Fig 1. Typical Output Characteristics

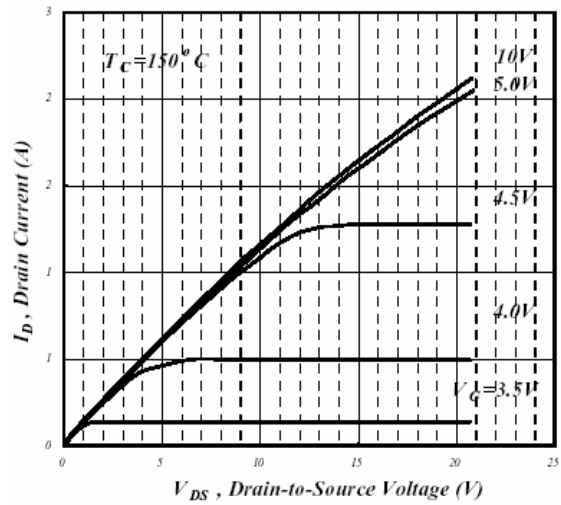


Fig 2. Typical Output Characteristics

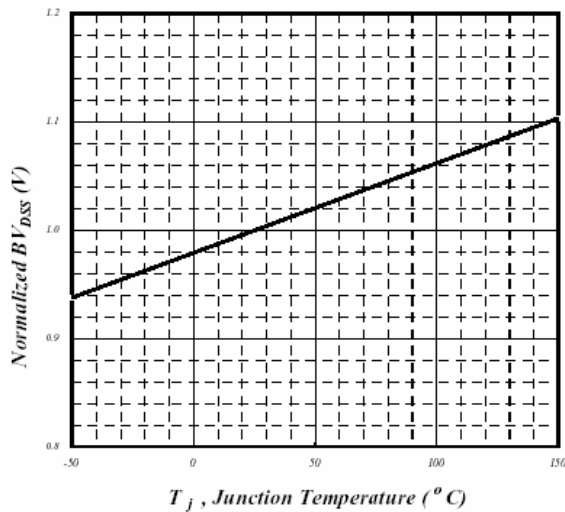


Fig 3. Normalized BV_{DSS} v.s. Junction Temperature

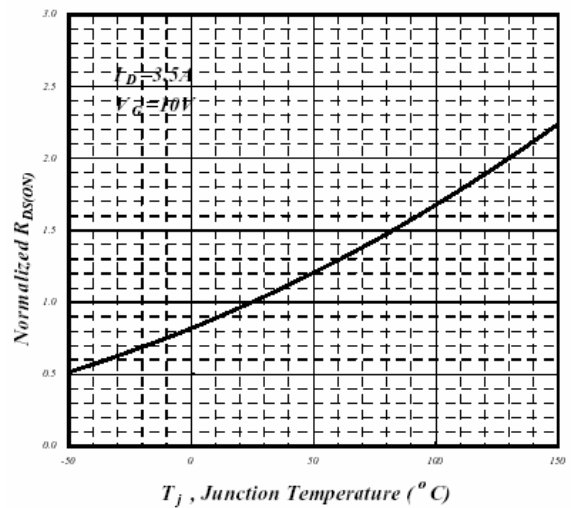


Fig 4. Normalized On-Resistance v.s. Junction Temperature

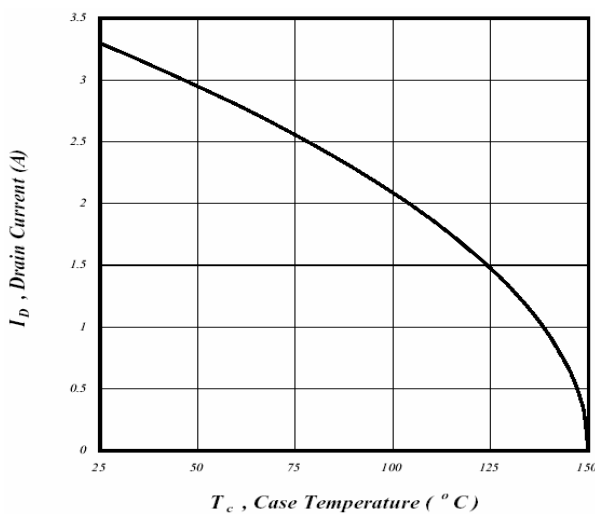


Fig 5. Maximum Drain Current v.s. Case Temperature

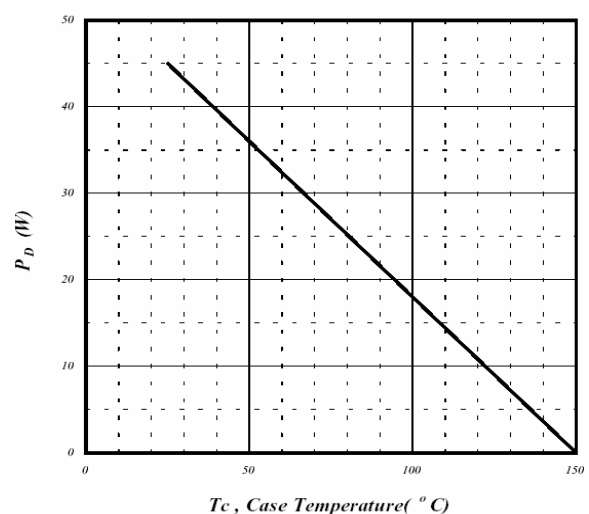


Fig 6. Type Power Dissipation

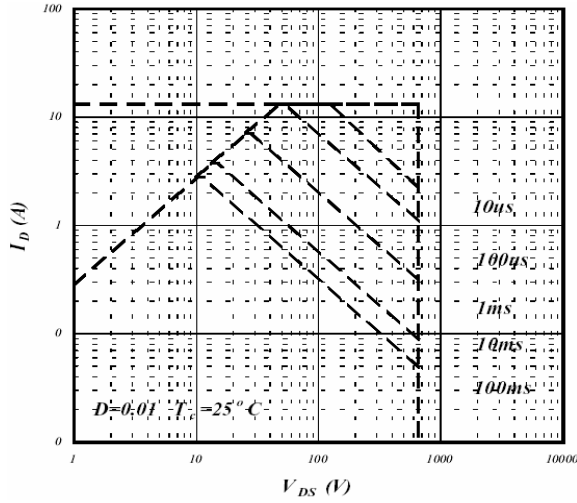


Fig 7. Maximum Safe Operating Area

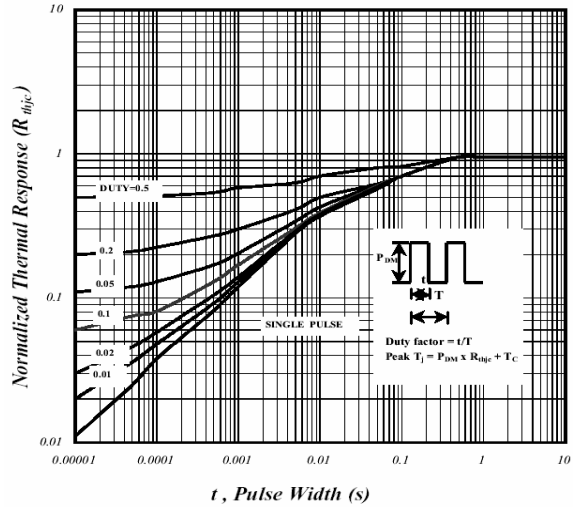


Fig 8. Effective Transient Thermal Impedance

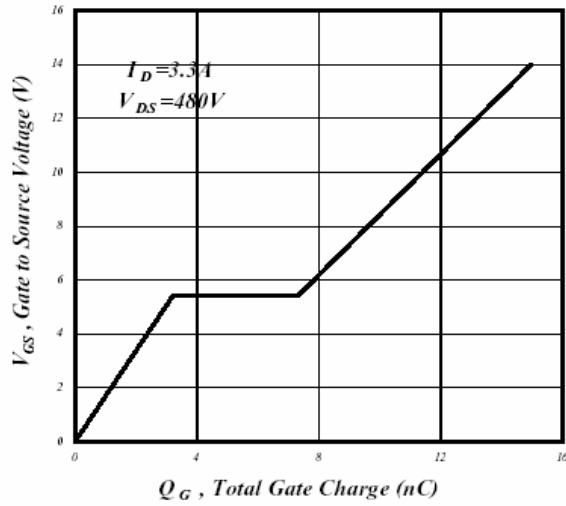


Fig 9. Gate Charge Characteristics

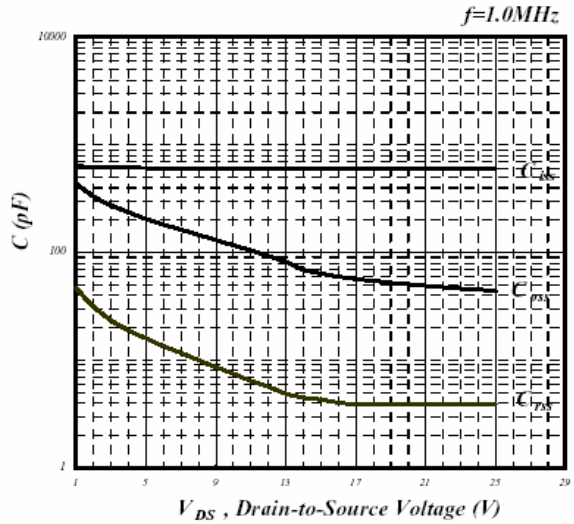


Fig 10. Typical Capacitance Characteristics

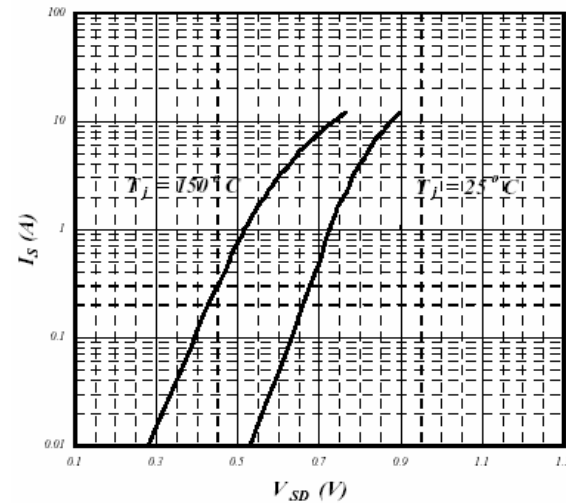


Fig 11. Forward Characteristics of Reverse Diode

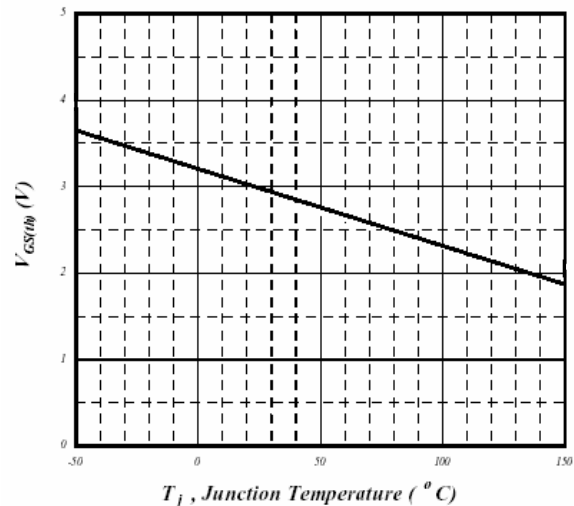
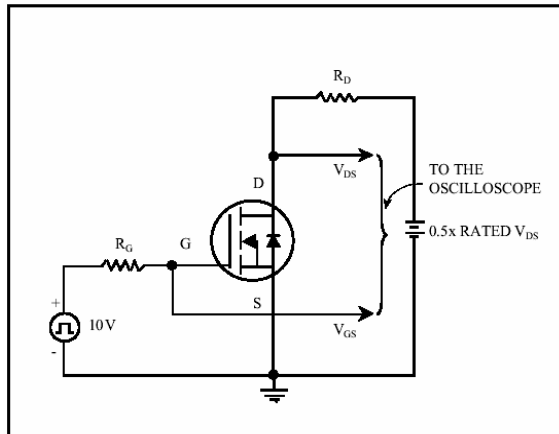
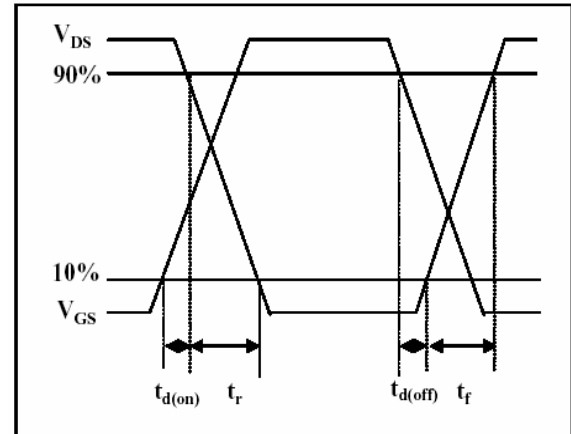
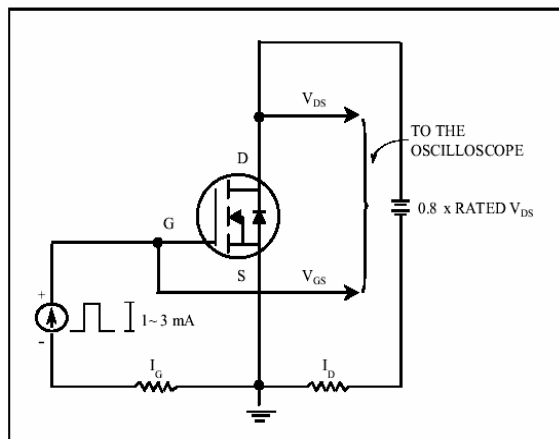
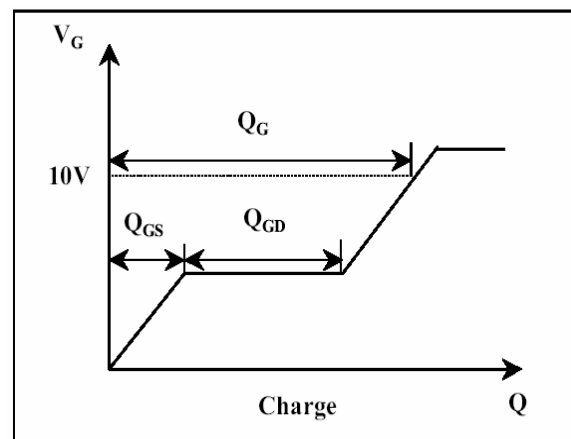


Fig 12. Gate Threshold Voltage v.s. Junction Temperature


Fig 13. Switching Time Circuit

Fig 14. Switching Time Waveform

Fig 15. Gate Charge Circuit

Fig 16. Gate Charge Waveform
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